Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/615,229	ITOI ET AL.
Examiner	Art Unit
 Y. Lee	2621

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Class	Subclass	Date	Examiner
375	240.26	4/25/2007	YL
348	48		
H04N	7/12		
update	search	9/11/2007	YL

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